

Search Notes

Application/Control No.

10/664,834

Examiner

Seung H. Lee

Applicant(s)/Patent under
Reexamination

FENG, CHEN

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	454	5/13/2005	SHL

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/16/2005	SHL
J. Fureman	5/16/2005	SHL
09/667919	5/16/2005	SHL